TOSHIBA Photocoupler GaAs Ired & Photo-Triac

# TLP665J(S)

Office Machine Household Use Equipment Triac Driver Solid State Relay

TOSHIBA TLP665J(S) consists of a photo-triac optically coupled to a gallium arsenide infrared emitting diode in a six lead plastic DIP package.

- Peak off-State voltage: 600V (Min.)
- Trigger LED current: 10mA (Max.)
- On-state current: 100mA (Max.)
- Isolation voltage: 5000Vrms (Min.)
- UL recognized: UL1577, file No. E67349
- SEMCO approved: EN60065, EN60950-1, EN60335-1

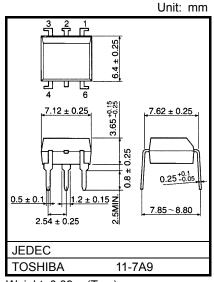
Certificate no.708960

- BSI approved: BS EN60065:2002, file No.8385 BS EN60950-1:2002, file No.8386
- Option(D4) type VDE approved: DIN EN 60747-5-2

Certificate No. 40009302

Maximum operating insulation voltage  $: 890V_{Pk}$ 

Highest permissible over voltage  $: 8000 V_{Pk}$ 



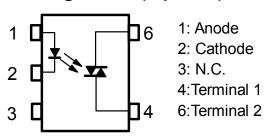
Weight: 0.39 g (Typ.)

(Note) When an EN60747-5-2 approved type is needed, please designate the "Option(D4)".

#### •Construction mechanical rating

	7.62 mm pich standard type	10.16 mm pich TLPXXXF type			
Creepage distance	7.0 mm (Min.)	8.0 mm (Min.)			
Clearance	7.0 mm (Min.)	8.0 mm (Min.)			
Insulation thickness	0.5 mm (Min.)	0.5 mm (Min.)			

#### Pin configuration (top view)



Absolute Maximum Ratings (Ta=25°C)

Characteristic			Symbol	Rating	Unit	
	Forward current			50	mA	
Ω	□ Forward current derating (Ta≥53°C)			-0.7	mA /°C	
LED	Peak forward current (100µs pulse, 100pps)		I <sub>FP</sub>	1	А	
	Reverse voltage			5	V	
	Off-State output terminal voltage	V <sub>DRM</sub>	600	V		
	On-state RMS current	Ta=25°C		100	mA	
5		Ta=70°C	I <sub>T(RMS)</sub>	50		
Detector	On-state current derating (Ta≥25°C)	∆I <sub>T</sub> /°C	-1.1	mA /°C		
ð	Peak on-state current (100µs pulse, 120pps)	I <sub>TP</sub>	2	А		
	Peak nonrepetitive surge current (Pw=10ms,DC=10%)	ITSM	1.2	А		
	Junction temperature	Tj	115	°C		
Ope	erating temperature range	T <sub>opr</sub>	-40~100	°C		
Stor	age temperature range	T <sub>stg</sub>	-55~125	°C		
Lea	Lead soldering temperature (10s)			260	°C	
Isola	Isolation voltage (AC,1min. , R.H.≤60%) (Note 2)			5000	Vrms	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

(Note 2) Pins1,2 and 3 shorted together and pin4 and pin6 shorted together.

#### **Recommended Operating Conditions**

Characteristic	Symbol	Min.	Тур.	Max.	Unit
Supply voltage	V <sub>AC</sub>	—	—	240	Vac
Forward current	١ <sub>F</sub>	15	20	25	mA
Peak on-state current	I <sub>TP</sub>	—	_	1	А
Operating temperature	T <sub>opr</sub>	-25	-	85	°C

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

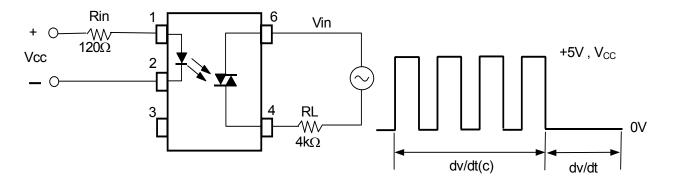
#### Electrical Characteristics (Ta=25°C)

	Characteristic	tic Symbol Test Condition		Min.	Тур.	Max.	Unit
	Forward voltage	VF	I <sub>F</sub> = 10 mA	1.0	1.15	1.3	V
LED	Reverse current	I <sub>R</sub>	V <sub>R</sub> = 5 V	_		10	μA
	Capacitance	CT	V = 0, f=1MHz	—	30	—	pF
L	Peak off-state current	I <sub>DRM</sub>	V <sub>DRM</sub> =600V	_	10	1000	nA
	Peak on-state voltage	V <sub>TM</sub>	I <sub>TM</sub> =100mA	_	1.7	3.0	V
Detector	Holding current	Ι <sub>Η</sub>	—	_	1.0	—	mA
Det	Critical rate of rise of off-state voltage	dv/dt	Vin=240Vrms , Ta=85°C (Note3)	_	500	_	V/µs
	Critical rate of rise of commutating voltage	dv/dt(c)	Vin=60Vrms , I <sub>T</sub> =15mA (Note3)	_	0.2	_	V/µs

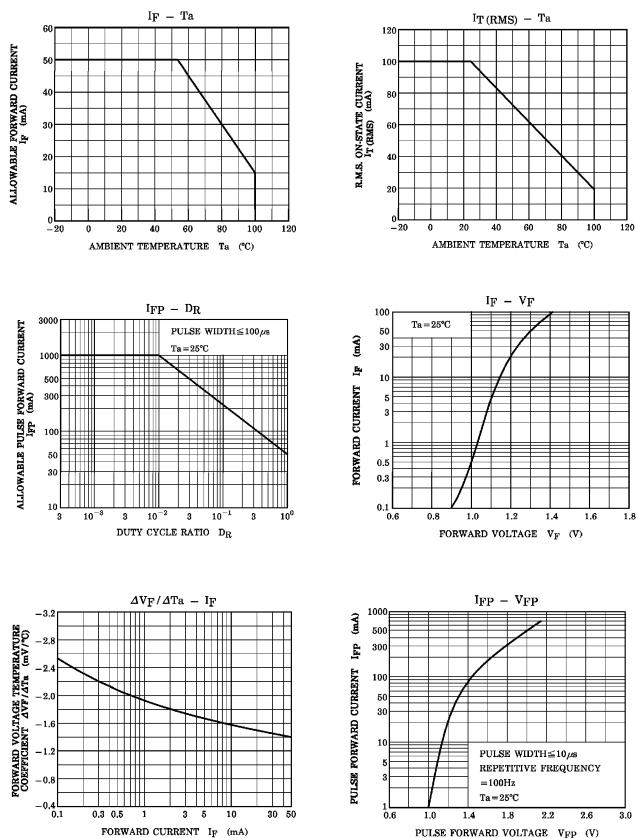
### Coupled Electrical Characteristics (Ta=25°C)

Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Trigger LED current	I <sub>FT</sub>	V <sub>T</sub> =6V	—	5	10	mA
Capacitance (input to output)	CS	V <sub>S</sub> =0 , f=1MHz	_	0.8	_	pF
Isolation resistance	R <sub>S</sub>	V <sub>S</sub> =500V	1×10 <sup>12</sup>	10 <sup>14</sup>	_	Ω
Isolation voltage	BVS	AC , 1minute	5000	_	_	Vrms
		AC , 1second,in oil	_	10000	_	
		DC , 1minute,in oil		10000		Vdc

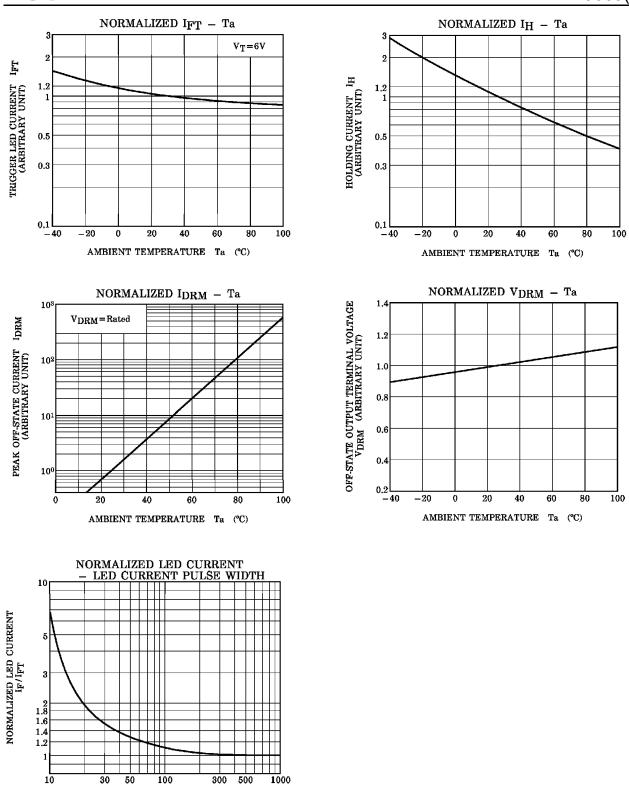
(Note 3) dv/dt test circuit



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LED CURRENT PULSE WIDTH  $P_W$  ( $\mu$ s)

#### **RESTRICTIONS ON PRODUCT USE**

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